

## 18. TEST PHOTOGRAPHS

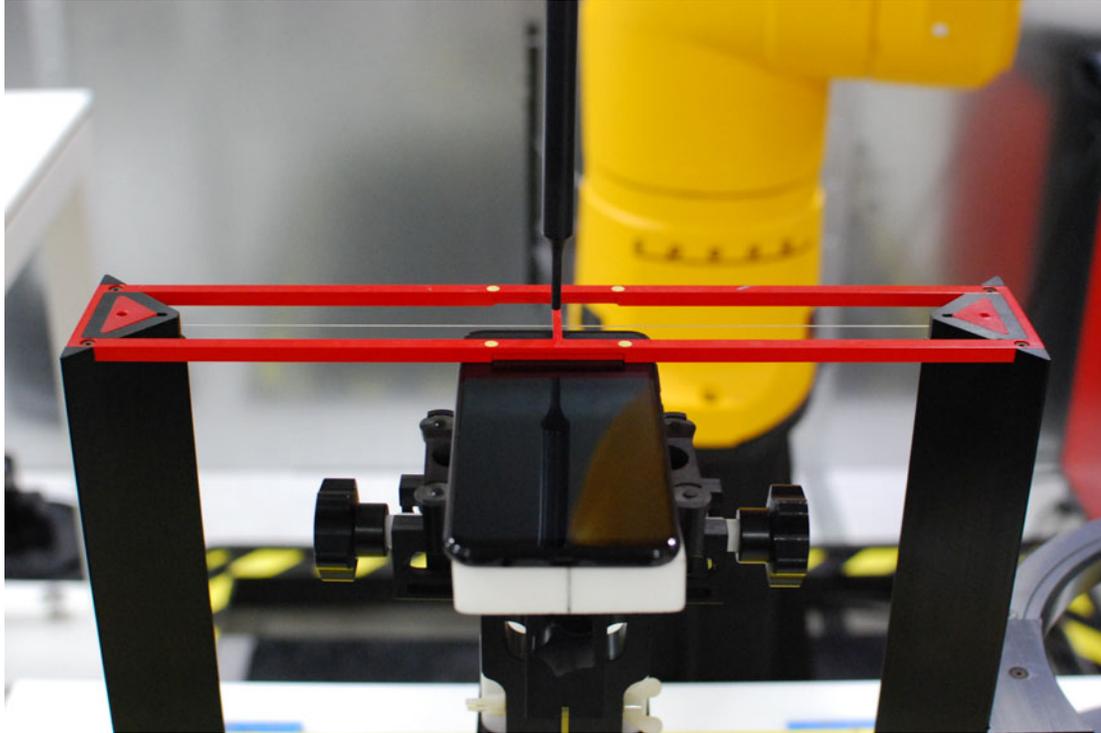
See following Attached Pages for setup photographs.

<b>FCC ID:</b> A3LSMA205U	 <b>PCTEST</b> ENGINEERING LABORATORY, INC.	<b>HAC (RF EMISSIONS) TEST REPORT</b>		<b>Approved by:</b> Quality Manager
<b>Filename:</b> 1M1904240065-13.A3L	<b>Test Dates:</b> 05/20/2019 - 05/22/2019	<b>DUT Type:</b> Portable Handset	Page 92 of 94	

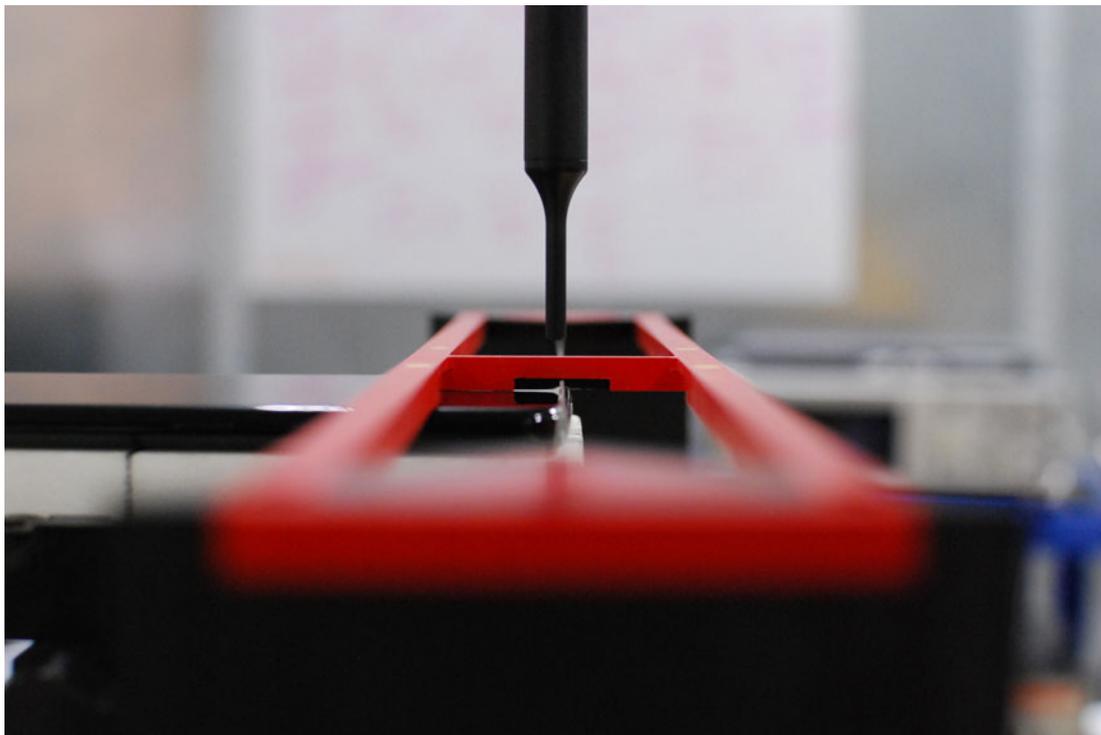
© 2019 PCTEST Engineering Laboratory, Inc.

REV 3.3.M  
2/1/2019

© 2019 PCTEST Engineering Laboratory, Inc. All rights reserved. Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from PCTEST Engineering Laboratory, Inc. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact [INFO@PCTEST.COM](mailto:INFO@PCTEST.COM).



**Figure 18-1**  
**Ear Reference Point HAC Phantom Alignment**



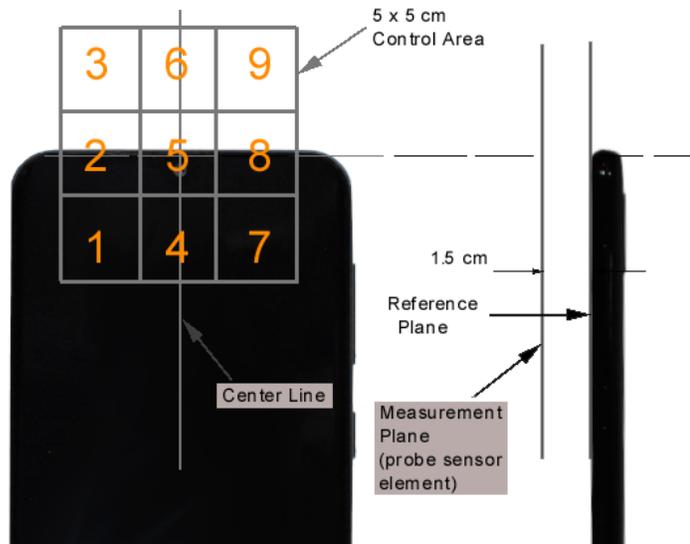
**Figure 18-2**  
**HAC Phantom Plane Alignment**

FCC ID: A3LSMA205U	 PCTEST ENGINEERING LABORATORY, INC.	HAC (RF EMISSIONS) TEST REPORT		Approved by: Quality Manager
Filename: 1M1904240065-13.A3L	Test Dates: 05/20/2019 - 05/22/2019	DUT Type: Portable Handset		Page 93 of 94

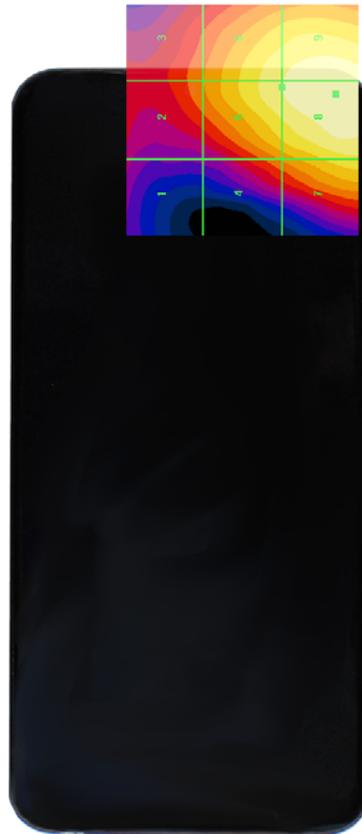
© 2019 PCTEST Engineering Laboratory, Inc.

REV 3.3.M  
2/1/2019

© 2019 PCTEST Engineering Laboratory, Inc. All rights reserved. Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from PCTEST Engineering Laboratory, Inc. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact [INFO@PCTEST.COM](mailto:INFO@PCTEST.COM).



**Figure 18-3 5x5 Scan grid above WD  
(Acoustic Centered scan area pictured)**



**Figure 18-4 E-Field WD Scan overlay  
(T-Coil Centered scan area pictured)**

FCC ID: A3LSMA205U	PCTEST ENGINEERING LABORATORY, INC.	HAC (RF EMISSIONS) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename: 1M1904240065-13.A3L	Test Dates: 05/20/2019 - 05/22/2019	DUT Type: Portable Handset		Page 94 of 94